

Search Notes**Application/Control No.**

10/047,758

Examiner

Raj K. Jain

Applicant(s)/Patent under Reexamination

CHANG, TU-YIIN

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
370	503,507	3/14/2006	RJ
370	509,518	3/14/2006	RJ
370	520	3/14/2006	RJ
375	354,356	3/14/2006	RJ
375	355,371	3/14/2006	RJ
375	372,373	3/14/2006	RJ
375	374,375	3/14/2006	RJ
375	376	3/14/2006	RJ

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted with Chi Pham for claims 1, 6 and 10. Claims contain 112 1 st issue.	3/14/2006	RJ
Consulted with Wellington Chin, concurred claims 6 and 10 contain 112 1 st issue.	3/15/2006	RJ
Searched US PGPUB, USPAT, TEXT SEARCH, SEE ATTACHED	3/14/2006	RJ

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner